## Applicant(s)/Patent Under Application/Control No. Reexamination 10/617,026 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Seokyun Moon 2629 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY \* US-2002/0075214 06-2002 Kim, Jong-Seon 345/88 Α US-В US-С US-D US-Ε US-F US-G US-Н USı US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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